

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 220680US0PCT		SERIAL NO. 10/088,522	
<div style="position: relative; width: 100px; height: 100px; margin: 0 auto;"> <div style="position: absolute; top: 0; left: 0; width: 100%; height: 100%; border: 1px solid black; border-radius: 50%; text-align: center; line-height: 100px; font-size: 12px;">             OIPE JUL 01 2002 PATENT &amp; TRADEMARK OFFICE           </div> </div> LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Francoise VINET, et al.			
				FILING DATE March 29, 2002		GROUP	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA	5,874,213	2/23/99	Cummins et al.			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO						
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW	K. Adelhelm, et al., "DEVELOPMENT OF A SENSITIVE DETECTION SYSTEM BASED ON THE PHOTOTHERMAL EFFECT FOR BIOMOLECULAR INTERACTION STUDIES," Biomedical Optoelectronics In Clinical Chemistry and Biotechnology, September 14, 1995, vol. 2629, pages 325-333					
	AX	Tamao Odake, et al., "HIGH-SPEED SEPARATION USING MINIATURIZED SLAB GEL AND HIGH SPATIAL RESOLUTION DETECTION BY THERMAL LENS MICROSCOPE," Proceedings of the 1998 Thermal Therapy, Laser Welding, and Tissue Interaction, September 9, 1998, vol. 3565, pages 126-133					
	AY	Takehiko Kitamori, "CHEMISTRY AND ANALYSIS IN INTERGRATED CHEMISTRY LAB ON CHIP," Digest of Papers, Microprocesses and Nanotechnology, 1999, pages 70-71					
	AZ						<input type="checkbox"/> Additional References sheet(s) attached
Examiner					Date Considered		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

RECEIVED

JUL 3 2002

TECH CENTER 1600/2900